

TRISIL FOR SLIC PROTECTION

FEATURES

- CROWBAR PROTECTION
- DUAL ASYMETRICAL TRANSIENT SUPPRESSOR
- PEAK PULSE CURRENT :
- $I_{PP} = 75 \text{ A}$, 10/1000 μs .
- HOLDING CURRENT = 150 mA min
- BREAKDOWN VOLTAGE = 58 V.
- BREAKOVER VOLTAGE = 80V max.

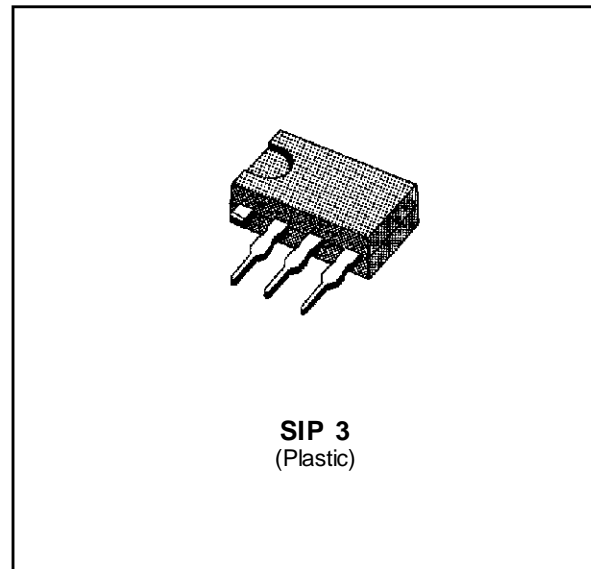
DESCRIPTION

This device has been especially designed to protect subscriber line card interfaces (SLIC) against transient overvoltages.

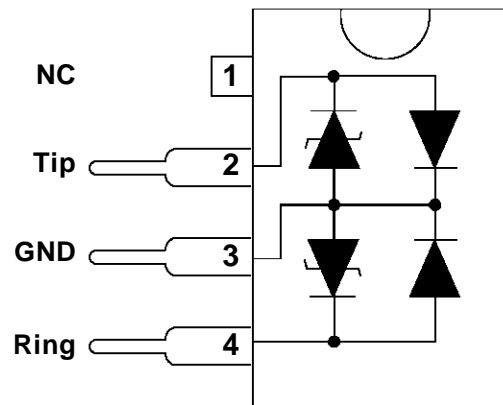
Its ion-implanted technology confers excellent electrical characteristics on it.

This is why this device easily fits the main protection standards which are related to the overvoltages on telecom lines.

This product is compatible with TO202 and TO220 packages.



SCHEMATIC DIAGRAM



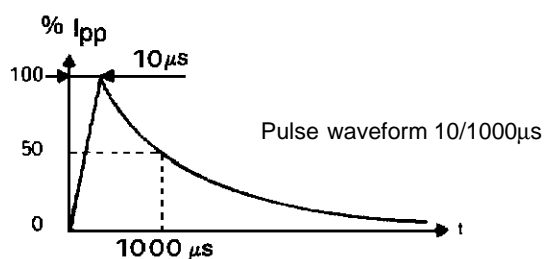
IN ACCORDANCE WITH FOLLOWING STANDARDS :

CCITT K17 - K20	{	10/700 μs	1.5 kV
		5/310 μs	38 A
VDE 0433	{	10/700 μs	2 kV
		5/200 μs	50 A
CNET	{	0.5/700 μs	1.5 kV
		0.2/310 μs	38 A

THDT58S

ABSOLUTE RATINGS (limiting values) ($-40^{\circ}\text{C} \leq T_{\text{amb}} \leq +85^{\circ}\text{C}$)

Symbol	Parameter		Value	Unit
I_{PP}	Peak pulse current	10/1000 μs 8/20 μs	75 150	A
I_{TSM}	Non repetitive surge peak on-state current	$t_p = 20 \text{ ms}$	30	A
I_{FSM}	Non repetitive surge peak forward current	$t_p = 20 \text{ ms}$	30	A
di/dt	Critical rate of rise of off-state current	Non repetitive	100	A/ μs
dv/dt	Critical rate of rise of off-state voltage	67% V_{BR}	5	KV/ μs
T_{stg} T_j	Storage and operating junction temperature range		- 40 to + 150 + 150	$^{\circ}\text{C}$ $^{\circ}\text{C}$
T_L	Maximum lead temperature for soldering during 10 s.		260	$^{\circ}\text{C}$

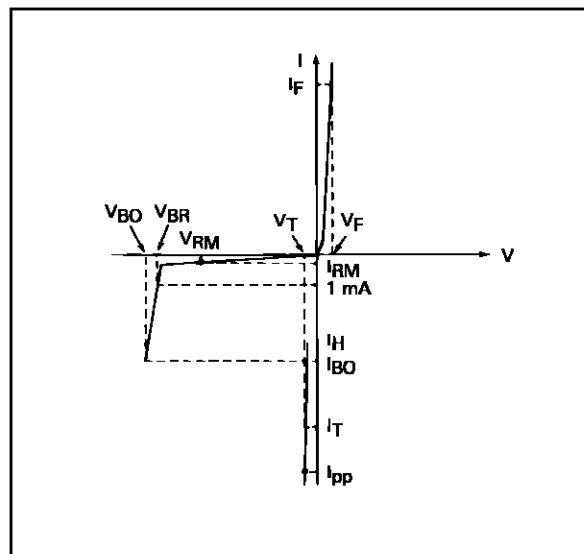


THERMAL RESISTANCE

Symbol	Parameter	Value	Unit
$R_{\text{th}} (j-a)$	Junction-to-ambient	70	$^{\circ}\text{C/W}$

ELECTRICAL CHARACTERISTICS

Symbol	Parameter
V_{RM}	Stand-off voltage
V_{BR}	Breakdown voltage
V_{BO}	Breakover voltage
I_H	Holding current
V_T	On-state voltage
V_F	Forward Voltage Drop
I_{BO}	Breakover current
I_{PP}	Peak pulse current



PARAMETER RELATED TO THE DIODE LINE/GND

Symbol	Test conditions	Value	Unit
V_F	Square pulse, $t_p = 500 \mu s$ $I_F = 5 A$.	5	V

PARAMETERS RELATED TO THE PROTECTION THYRISTOR

Type	I_{RM} @ V_{RM}		V_{BR} @ I_R		V_{BO} @ I_{BO}			I_H	V_T	C
	max		min		max	min	max	min	max	max
	μA	V	V	mA	V	mA	mA	mA	V	pF
THDT58S	10	56	58	1	80	150	800	150	5	400

All parameters tested at 25°C, except where indicated

Note 1 : See the reference test circuit for I_H , I_{BO} and V_{BO} parameters.

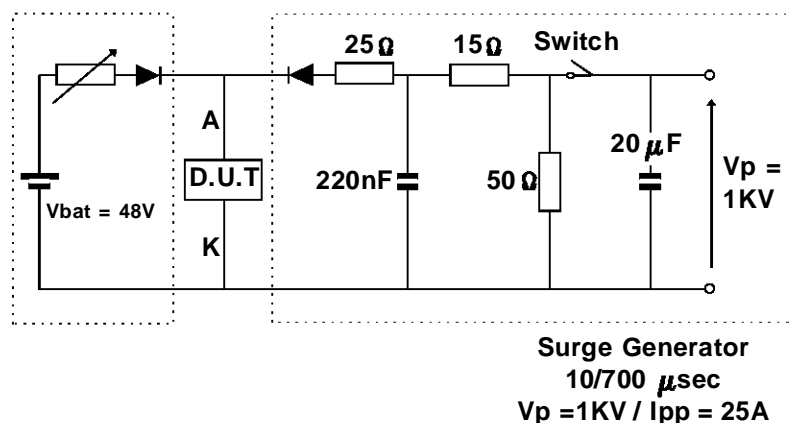
Note 2 : Square pulse $T_p = 500 \mu s$ - $I_T = 5A$.

Note 3 : $V_R = 1V$, $F = 1MHz$.



- Pulse Test duration ($T_p = 20\text{ms}$):
 - For Bidirectional devices = Switch K is closed
 - For Unidirectional devices = Switch K is open.
- V_{OUT} Selection
 - Device with $V_{BR} \leq 150\text{ Volt}$
 - $V_{OUT} = 250 V_{RMS}$, $R_1 = 140\ \Omega$.
 - Device with $V_{BR} \geq 150\text{ Volt}$
 - $V_{OUT} = 480 V_{RMS}$, $R_2 = 240\ \Omega$.

FUNCTIONAL HOLDING CURRENT (I_H) TEST CIRCUIT = GO - NOGO TEST.



This is a GO-NOGO Test which allows to confirm the holding current (I_H) level in a functional test circuit. This test can be performed if the reference test circuit can't be implemented.

TEST PROCEDURE :

- 1) Adjust the current level at the I_H value by short circuiting the AK of the D.U.T.
- 2) Fire the D.U.T with a surge Current : $I_{pp} = 25A$, $10/700 \mu s$.
- 3) The D.U.T will come back to the OFF-State withing a duration of 50 ms max.

Figure 1 : Relative variation of holding current versus junction temperature.

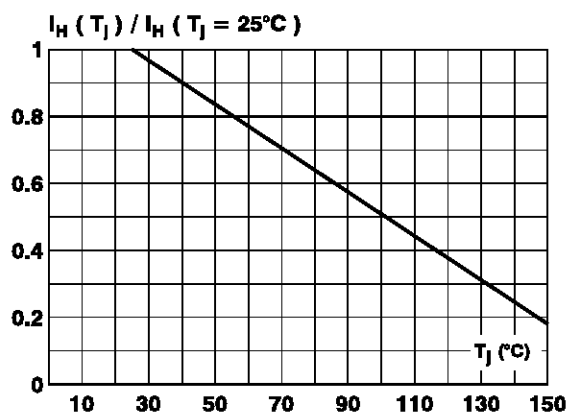


Figure 2 : Non repetitive surge peak on state current versus number of cycles (1 cycle = 20 ms).

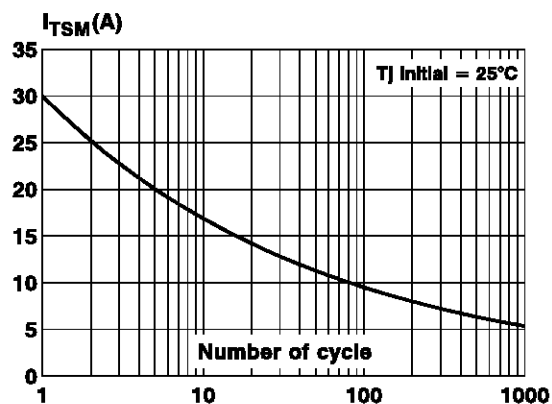


Figure 3 : Peak on state voltage versus peak on state current (typical values).

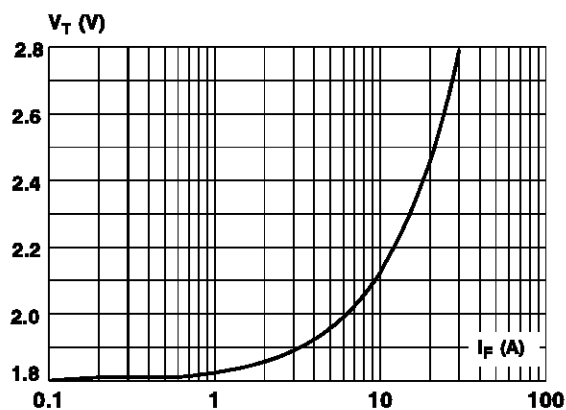


Figure 4 : Peak forward voltage drop versus peak forward current (typical values).

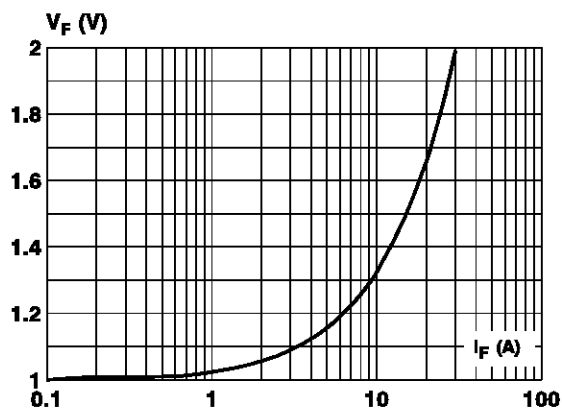
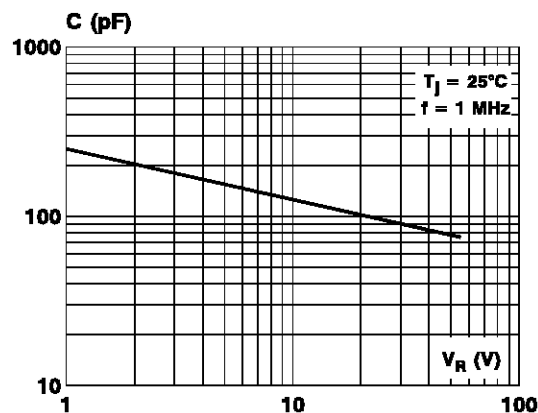
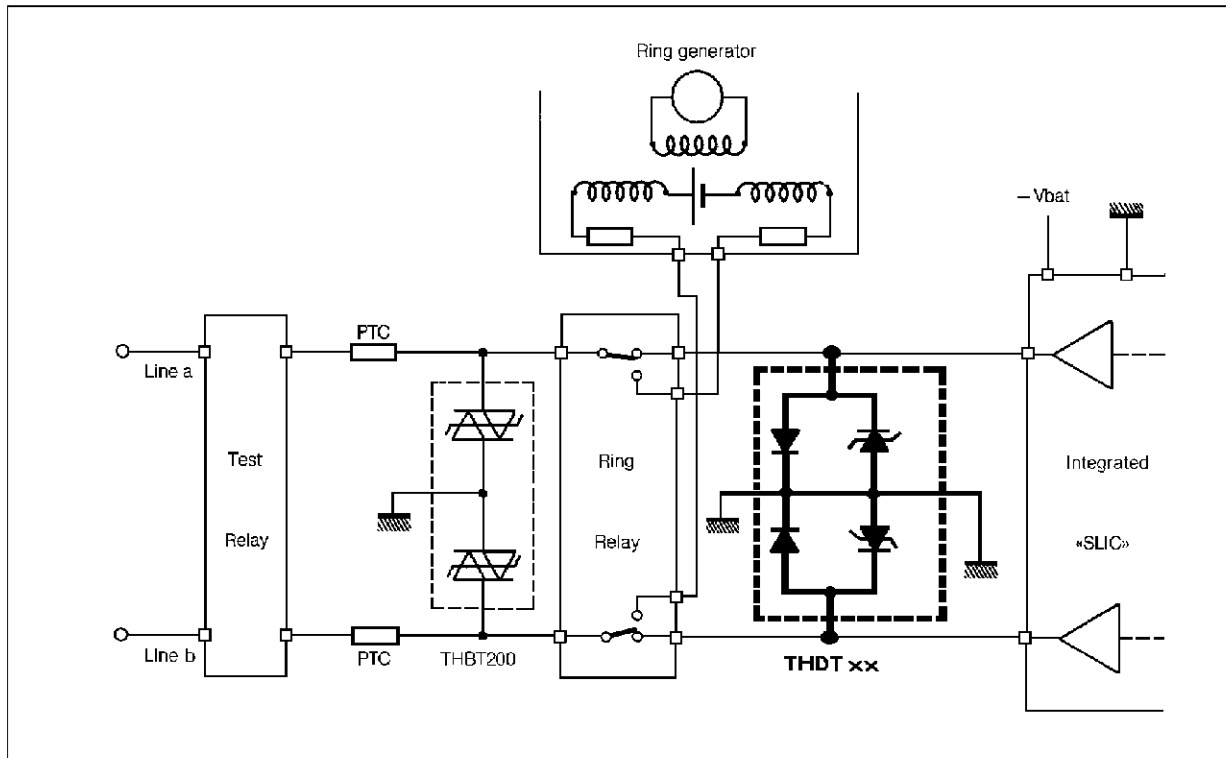


Figure 5 : Capacitance versus reverse applied voltage (typical values).

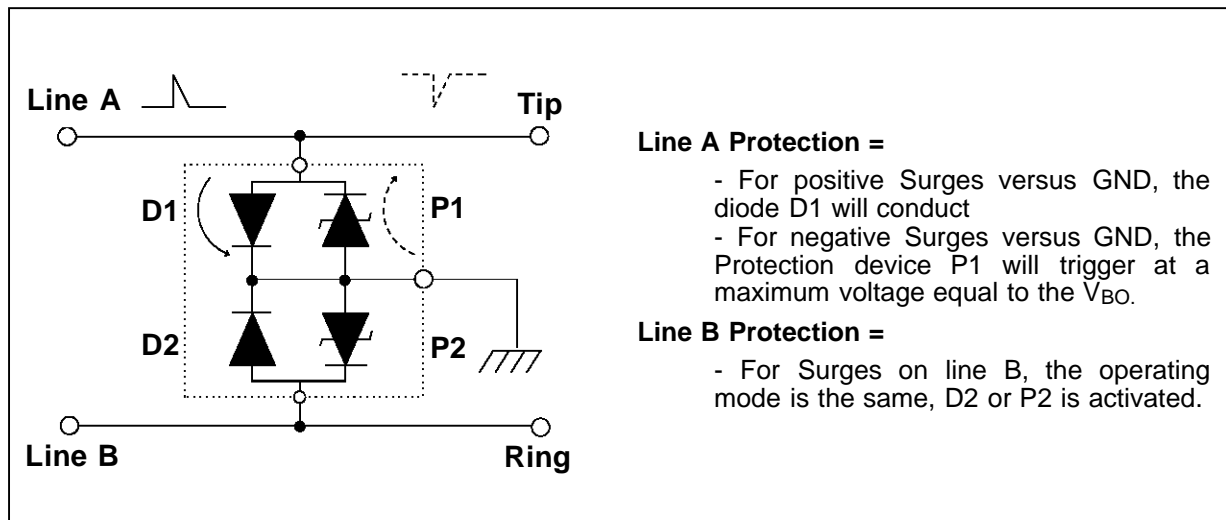


APPLICATION CIRCUIT

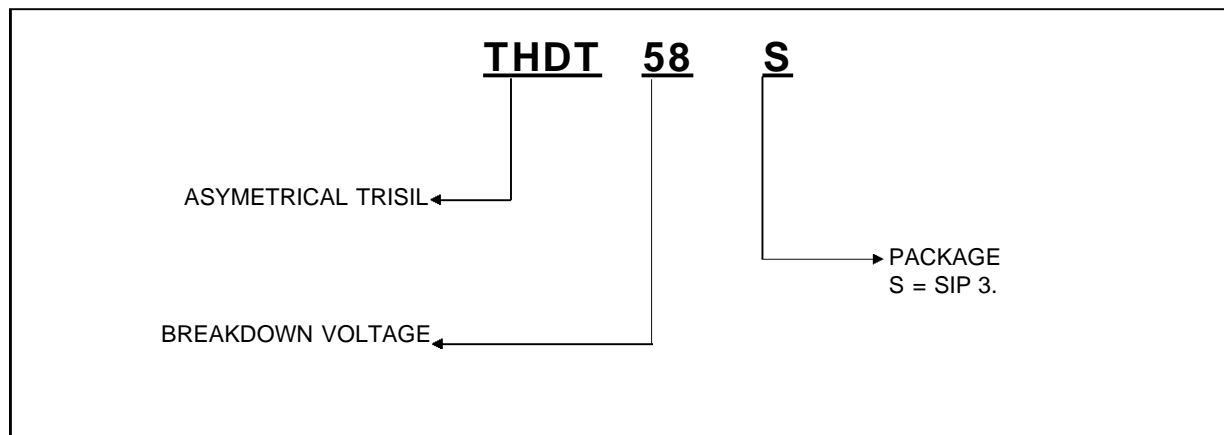
Typical slic protection concept



FUNCTIONAL DESCRIPTION



ORDER CODE

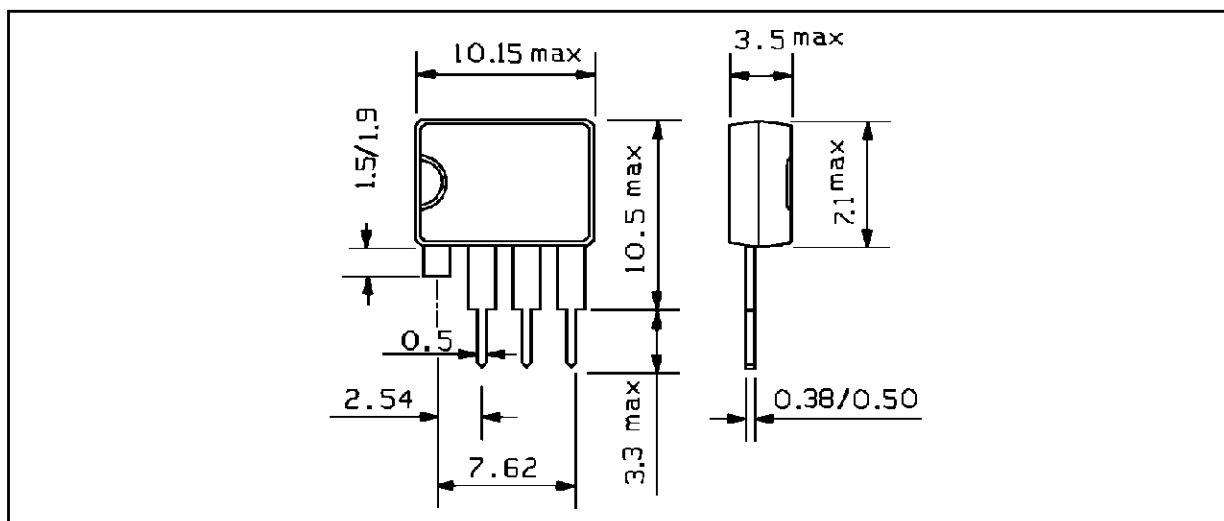


MARKING

Package	Type	Marking
SIP3	THDT58S	THDT58S

PACKAGE MECHANICAL DATA (in millimeters)

SIP 3 Plastic.

**Packaging** : Products supplied in antistatic tubes.

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